

HIGH EFFICIENCY FAST RECOVERY RECTIFIER DIODES

- VERY LOW CONDUCTION LOSSES
- NEGLIGIBLE SWITCHING LOSSES
- LOW FORWARD AND REVERSE RECOVERY TIMES
- HIGH SURGE CURRENT
- THE SPECIFICATIONS AND CURVES ENABLE THE DETERMINATION OF t_{rr} AND I_{RM} AT 100°C UNDER USERS CONDITIONS



F 126
(Plastic)

DESCRIPTION

Low voltage drop and rectifier suited for switching mode base drive and transistor circuits.

ABSOLUTE RATINGS (limiting values)

Symbol	Parameter	Value	Unit
I_{FRM}	Repetitive Peak Forward Current	50	A
I_F (AV)	Average Forward Current*	1.5	A
I_{FSM}	Surge non Repetitive Forward Current	50	A
P_{tot}	Power Dissipation*	1.3	W
T_{stg} T_j	Storage and Junction Temperature Range	- 40 to + 150 - 40 to + 150	°C
T_L	Maximum Lead Temperature for Soldering during 10s at 4mm from Case	230	°C

Symbol	Parameter	BYW 100-				Unit
		50	100	150	200	
V_{RRM}	Repetitive Peak Reverse Voltage	50	100	150	200	V
V_{RSM}	Non Repetitive Peak Reverse Voltage	55	110	165	220	V

THERMAL RESISTANCE

Symbol	Parameter	Value	Unit
$R_{th} (j - a)$	Junction-ambient*	45	°C/W

* On infinite heatsink with 10mm lead length.

BYW 100-50 → 200

ELECTRICAL CHARACTERISTICS

STATIC CHARACTERISTICS

Symbol	Test Conditions		Min.	Typ.	Max.	Unit
I_R	$T_j = 25^\circ C$	$V_R = V_{RRM}$			10	μA
	$T_j = 100^\circ C$				0.5	mA
V_F	$T_j = 25^\circ C$	$I_F = 4.5A$			1.2	V
	$T_j = 100^\circ C$	$I_F = 1.5A$			0.85	

RECOVERY CHARACTERISTICS

Symbol	Test Conditions			Min.	Typ.	Max.	Unit
t_{rr}	$T_j = 25^\circ C$ $V_R = 30V$	$I_F = 1A$ See figure 10	$di_F/dt = -50A/\mu s$			35	ns
Q_{rr}	$T_j = 25^\circ C$ $V_R \leq 30V$	$I_F = 1A$	$di_F/dt = -20A/\mu s$		10		nC
t_{fr}	$T_j = 25^\circ C$ Measured at $1.1 \times V_F$	$I_F = 1A$	$t_r = 10ns$		30		ns
V_{FP}	$T_j = 25^\circ C$	$I_F = 1A$	$t_r = 10ns$		5		V

To evaluate the conduction losses use the following equations:

$$V_F = 0.66 + 0.075 I_F$$

$$P = 0.06 \times I_F(AV) + 0.075 I_F^2(RMS)$$

Figure 1. Maximum average power dissipation versus average forward current.

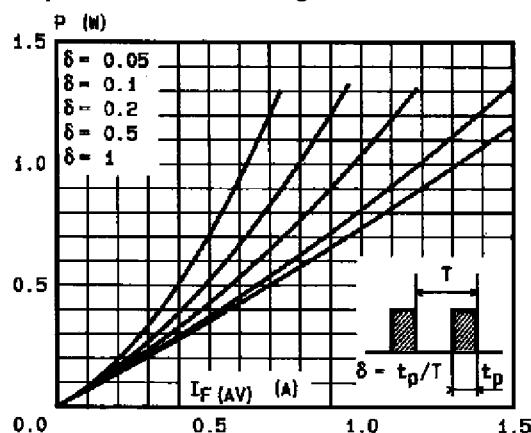


Figure 2. Average forward current versus ambient temperature.

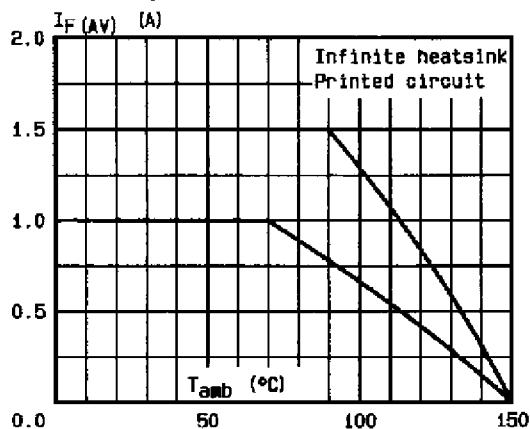


Figure 3. Thermal resistance versus lead length.

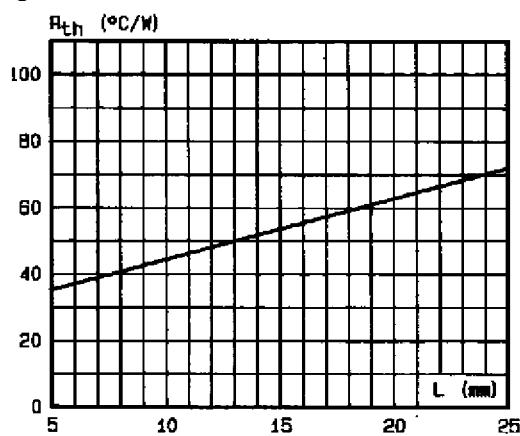
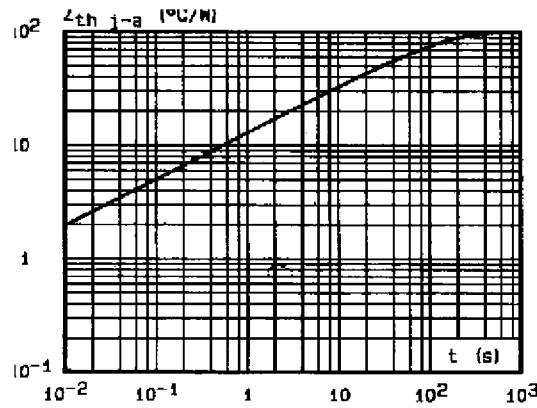


Figure 4. Transient thermal impedance junction-ambient for mounting n°2 versus pulse duration ($L = 10$ mm).



**Mounting n°1
INFINITE HEATSINK**

**Mounting n°2
PRINTED CIRCUIT**

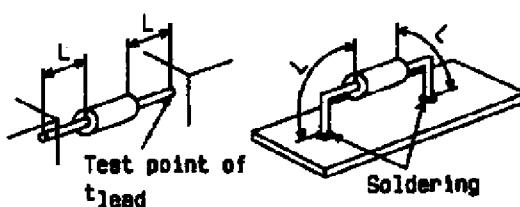


Figure 5. Peak forward current versus peak forward voltage drop (maximum values).

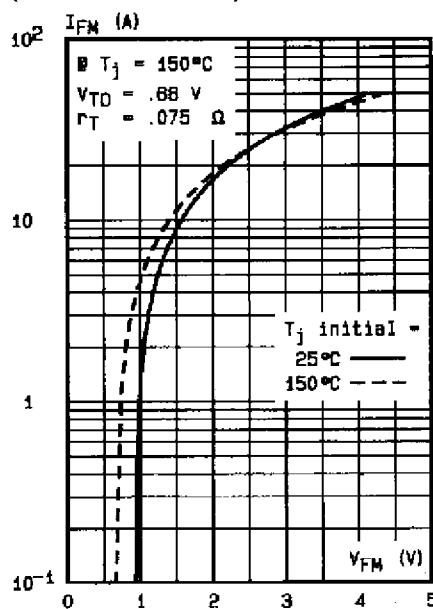


Figure 6. Capacitance versus reverse voltage applied.

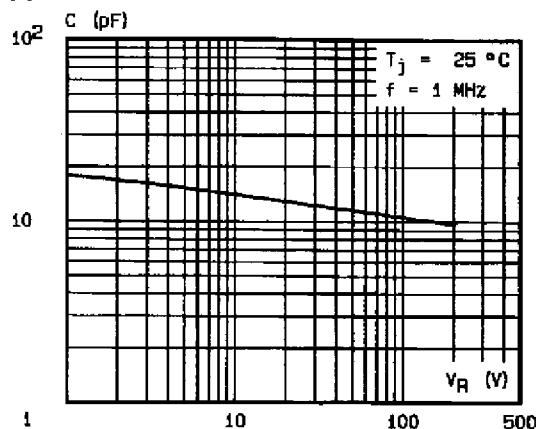


Figure 7. Recovery time versus di_F/dt .

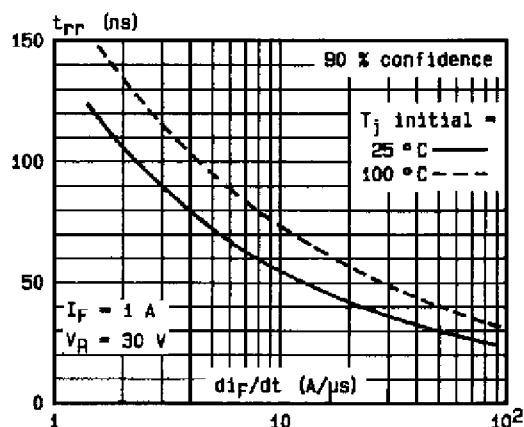


Figure 8. Peak reverse current versus di_F/dt .

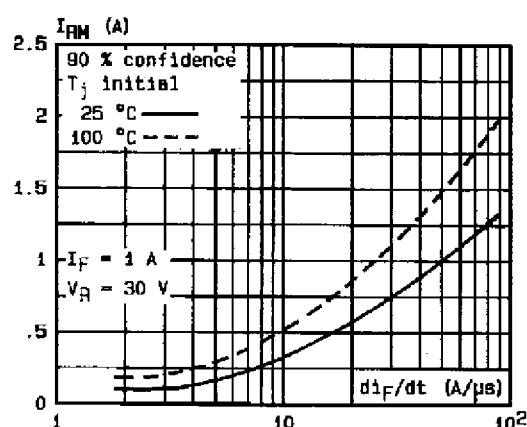


Figure 9. Dynamic parameters versus junction temperature.

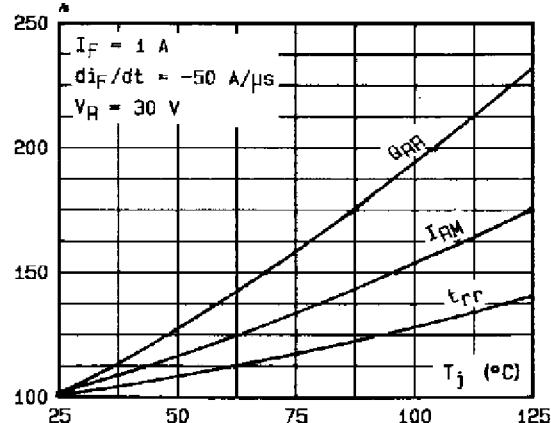
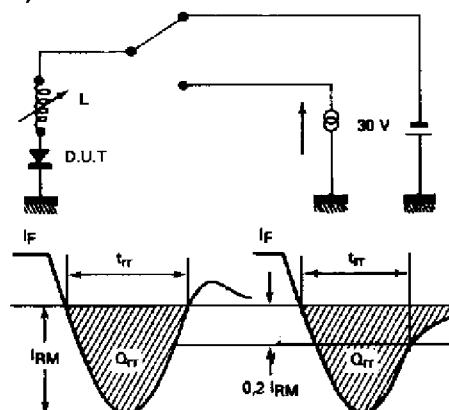
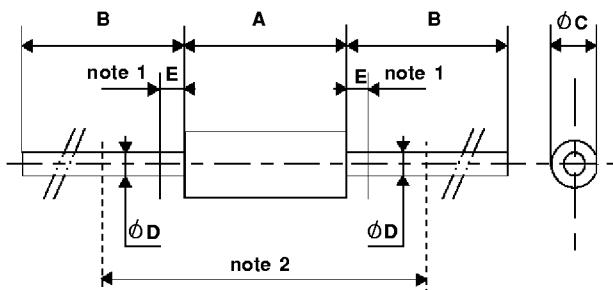


Figure 10. Measurement of t_{rr} (Fig. 7) and I_{RM} (Fig. 8).



PACKAGE MECHANICAL DATA

F 126 (Plastic)



REF.	DIMENSIONS				NOTES	
	Millimeters		Inches			
	Min.	Max.	Min.	Max.		
A	6.05	6.35	0.238	0.250	1 - The lead diameter \varnothing D is not controlled over zone E	
B	26		1.024		2 - The minimum axial length within which the device may be placed with its leads bent at right angles is 0.59" (15 mm)	
\varnothing C	2.95	3.05	0.116	0.120		
\varnothing D	0.76	0.86	0.029	0.034		
E		1.27		0.050		

Cooling method: by convection (method A)

Marking: type number

Weight: 0.4g

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